

3-Level NPC1 Inverter Module

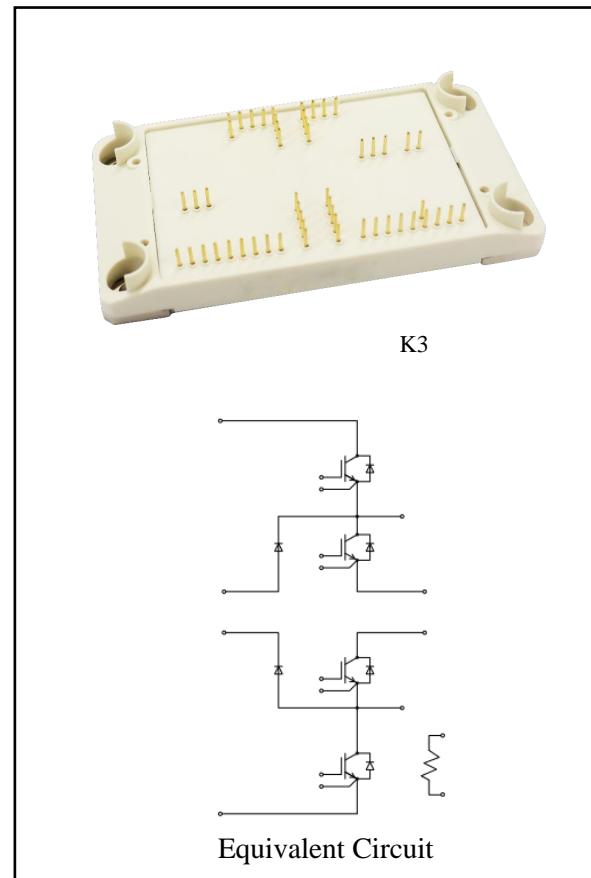
$V_{CES}=1200V$, $I_{C\text{ nom}}=225A$ / $I_{CRM}=450A$

Features :

- 1200V Trench / Field Stop Technology
- Low switching losses
- V_{cesat} has a positive temperature coefficient

Applications:

- Energy Storage System
- Solar Inverters
- Uninterruptable Power Supplies Systems



IGBT, T1/T4

Maximum Ratings

Parameter	Conditions	Symbol	Value		Unit
Collector-Emitter voltage	$T_{vj}=25^\circ C$	V_{CES}	1200		V
Continuous DC collector current		$I_{C\text{ nom}}$	225		A
Repetitive peak collector current		I_{CRM}	450		A
Gate emitter voltage		V_{GE}	± 20		V

Characteristic Values

Parameter	Conditions	Symbol	Value			Unit
			Min.	Typ.	Max.	
Collector-Emitter saturation voltage	$V_{GE}=15V$, $I_c=225A$ $V_{GE}=15V$, $I_c=225A$ $V_{GE}=15V$, $I_c=225A$	V_{CEsat}	$T_{vj}=25^\circ C$ $T_{vj}=125^\circ C$ $T_{vj}=150^\circ C$	1.75 2.14 2.22	2.25	V

Gate-Emitter threshold voltage	I _c =7.8mA, V _{GE} = V _{CE}	T _{vj} =25°C	V _{GE(th)}	5.50	6.10	6.70	
Gate charge	V _{GE} =-15V...+15V		Q _G		2.10		µC
Internal gate resistor			R _{Gint}	--			Ω
Input capacitance	f=1MHz, V _{CE} =25 V, V _{GE} =0 V	T _{vj} =25°C	C _{ies}	34.5			nF
Reverse transfer capacitance			C _{res}	0.23			nF
Collector-emitter cut-off current	V _{CE} =1200V , V _{GE} = 0 V	T _{vj} =25°C	I _{CES}		1		mA
Gate-emitter leakage current	V _{CE} =0 V, V _{GE} = 20 V	T _{vj} =25°C	I _{GES}		100		nA
Turn-on delay time	I _c =225A, V _{CE} =600 V V _{GE} =±15 V, R _G =5Ω (inductive load)	T _{vj} =25°C T _{vj} =125°C T _{vj} =150°C	t _{d on}		108		ns
Rise time	I _c =225A, V _{CE} =600 V V _{GE} =±15 V, R _G =5Ω (inductive load)	T _{vj} =25°C T _{vj} =125°C T _{vj} =150°C	t _r		54		
Turn-off delay time	I _c =225A, V _{CE} =600 V V _{GE} =±15 V, R _G =5Ω (inductive load)	T _{vj} =25°C T _{vj} =125°C T _{vj} =150°C	t _{d off}		270		
Fall time	I _c =225A, V _{CE} =600 V V _{GE} =±15 V, R _G =5Ω (inductive load)	T _{vj} =25°C T _{vj} =125°C T _{vj} =150°C	t _f		83		
Turn-on energy loss per pulse	I _c =225A, V _{CE} =600 V V _{GE} =±15 V, R _G =5Ω di/dt = 3100 A/µs (T _{vj} = 150 °C)	T _{vj} =25°C T _{vj} =125°C T _{vj} =150°C	E _{on}		17.7		mJ
Turn-off energy loss per pulse	I _c =225A, V _{CE} =600 V V _{GE} =±15 V, R _G =5Ω dv/dt = 8400 V/µs (T _{vj} = 150 °C)	T _{vj} =25°C T _{vj} =125°C T _{vj} =150°C	E _{off}		22.8		
Thermal resistance, junction to case	per IGBT		R _{thJC}		0.183		K/W
Temperature under switching conditions			T _{vj op}	-40		175	°C

IGBT, T2/T3

Maximum Ratings

Parameter	Conditions	Symbol	Value	Unit
Collector-Emitter voltage	T _{vj} =25°C	V _{CES}	1200	V
Continuous DC collector current		I _{C nom}	225	A
Repetitive peak collector current		I _{CRM}	450	A

Gate emitter voltage		V _{GE}	±20	V
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Characteristic Values

Parameter	Conditions	Symbol	Value			Unit
			Min.	Typ.	Max.	
Collector-Emitter saturation voltage	V _{GE} =15V, I _c =225A V _{GE} =15V, I _c =225A V _{GE} =15V, I _c =225A	T _{vj} =25°C T _{vj} =125°C T _{vj} =150°C	V _{CEsat}	1.75 2.14 2.22	2.25	V
Gate-Emitter threshold voltage	I _c =7.8mA, V _{GE} = V _{CE}	T _{vj} =25°C		5.50	6.10	
Gate charge	V _{GE} =-15V...+15V	Q _G		2.10		µC
Internal gate resistor		R _{Gint}		--		Ω
Input capacitance	f=1MHz, V _{CE} =25 V, V _{GE} =0 V	C _{ies}		34.5		nF
Reverse transfer capacitance		C _{res}		0.23		nF
Collector-emitter cut-off current	V _{CE} =1200V , V _{GE} = 0 V	T _{vj} =25°C	I _{CES}		1	mA
Gate-emitter leakage current	V _{CE} =0 V, V _{GE} = 20 V	T _{vj} =25°C	I _{GES}		100	nA
Turn-on delay time	I _c =225A, V _{CE} =600 V V _{GE} =±15 V, R _G =5Ω (inductive load)	T _{vj} =25°C T _{vj} =125°C T _{vj} =150°C	t _{d on}	108 92 97		ns
Rise time	I _c =225A, V _{CE} =600 V V _{GE} =±15 V, R _G =5Ω (inductive load)	T _{vj} =25°C T _{vj} =125°C T _{vj} =150°C		62 63 66		
Turn-off delay time	I _c =225A, V _{CE} =600 V V _{GE} =±15 V, R _G =5Ω (inductive load)	T _{vj} =25°C T _{vj} =125°C T _{vj} =150°C	t _{d off}	266 293 303		mJ
Fall time	I _c =225A, V _{CE} =600 V V _{GE} =±15 V, R _G =5Ω (inductive load)	T _{vj} =25°C T _{vj} =125°C T _{vj} =150°C		68 108 120		
Turn-on energy loss per pulse	I _c =225A, V _{CE} =600 V V _{GE} =±15 V, R _G =5Ω di/dt = 2700 A/µs (T _{vj} = 150 °C)	Tvj=25°C Tvj=125°C Tvj=150°C	E _{on}	18.0 21.2 22.5		
Turn-off energy loss per pulse	I _c =225A, V _{CE} =600 V V _{GE} =±15 V, R _G =5Ω dv/dt = 8300 V/µs (T _{vj} = 150 °C)	Tvj=25°C Tvj=125°C Tvj=150°C		7.70 10.9 11.7		
Thermal resistance, junction to case	per IGBT	R _{thJC}		0.183		K/W
Temperature under switching conditions		T _{vj op}	-40		175	°C

Diode,D1/D4

Maximum Ratings

Parameter	Conditions	Symbol	Value	Unit
Repetitive peak reverse voltage	T _{vj} =25°C	V _{RRM}	1200	V
Continuous DC forward current		I _F	300	A
Repetitive peak forward current		I _{FRM}	600	A
I ² t-value	t _p =10ms, sin180° , T _j =125°C	I ² t	20000	A ² S

Characteristic Values

Parameter	Conditions	Symbol	Value			Unit
			Min.	Typ.	Max.	
Forward voltage	I _F =300A, V _{GE} =0V	V _F		1.55		V
	I _F =300A, V _{GE} =0V			1.68		
	I _F =300A, V _{GE} =0V			1.66		
Peak reverse recovery current	I _F =300A,	I _{RM}		140		A
	-dI _F /dt=3000A/μs(T _{vj} =150°C)			179		
	V _R =600V, V _{GE} =-15V			218		
Recovered charge	I _F =300A,	Q _r		25.3		μC
	-dI _F /dt=3000A/μs(T _{vj} =150°C)			44.1		
	V _R =600V, V _{GE} =-15V			61.5		
Reverse recovered energy	I _F =300A,	E _{rec}		9.30		mJ
	-dI _F /dt=3000A/μs(T _{vj} =150°C)			17.6		
	V _R =600V, V _{GE} =-15V			20.5		
Thermal resistance, junction to case	per diode	R _{thJC}		0.323		K/W
Temperature under switching conditions		T _{vj op}	-40		175	°C

Diode,D2/D3

Maximum Ratings

Parameter	Conditions	Symbol	Value	Unit
Repetitive peak reverse voltage	T _{vj} =25°C	V _{RRM}	1200	V
Continuous DC forward current		I _F	200	A
Repetitive peak forward current		I _{FRM}	400	A
I ² t-value	t _p =10ms, sin180° , T _j =125°C	I ² t	10000	A ² S

Characteristic Values

Parameter	Conditions	Symbol	Value			Unit
			Min.	Typ.	Max.	
Forward voltage	I _F =200A, V _{GE} =0V	V _F		1.58		V
	I _F =200A, V _{GE} =0V			1.70		
	I _F =200A, V _{GE} =0V			1.66		
Peak reverse recovery current	I _F =200A,	I _{RM}		122		A
	-dI/dt=2800A/μs(T _{vj} =150°C)			141		
	V _R =600V, V _{GE} =-15V			147		
Recovered charge	I _F =200A,	Q _r		18.3		μC
	-dI/dt=2800A/μs(T _{vj} =150°C)			29.8		
	V _R =600V, V _{GE} =-15V			34.2		
Reverse recovered energy	I _F =200A,	E _{rec}		6.90		mJ
	-dI/dt=2800A/μs(T _{vj} =150°C)			11.9		
	V _R =600V, V _{GE} =-15V			13.7		
Thermal resistance, junction to case	per diode	R _{thJC}		0.39		K/W
Temperature under switching conditions		T _{vj op}	-40		175	°C

Diode,D5/D6
Maximum Ratings

Parameter	Conditions	Symbol	Value		Unit
Repetitive peak reverse voltage	T _{vj} =25°C	V _{RRM}	1200		V
Continuous DC forward current		I _F	300		A
Repetitive peak forward current		I _{FRM}	600		A
I ² t-value	t _p =10ms, sin180° , T _j =125°C	I ² t	14000		A ² S

Characteristic Values

Parameter	Conditions	Symbol	Value			Unit
			Min.	Typ.	Max.	
Forward voltage	I _F =300A, V _{GE} =0V	V _F		1.64		V
	I _F =300A, V _{GE} =0V			1.79		
	I _F =300A, V _{GE} =0V			1.75		
Peak reverse recovery current	I _F =300A,	I _{RM}		154		A
	-dI/dt=3400A/μs(T _{vj} =150°C)			192		
	V _R =600V, V _{GE} =-15V			221		
Recovered charge	I _F =300A,	Q _r		9.62		μC
	-dI/dt=3400A/μs(T _{vj} =150°C)			44.1		
	V _R =600V, V _{GE} =-15V			49.6		

Reverse recovered energy	I _F =300A, -dI/dt=3400A/μs(T _{vj} =150°C) V _R =600V, V _{GE} =-15V	T _{vj} =25°C T _{vj} =125°C T _{vj} =150°C	E _{rec}		6.90 18.1 19.7		mJ
Thermal resistance, junction to case	per diode		R _{thJC}		0.37		K/W
Temperature under switching conditions			T _{vj op}	-40		175	°C

NTC-Thermistor

Characteristic Values

Parameter	Conditions	Value			Unit
R ₂₅	T=25°C		5		KΩ
△R/R		-5		5	%
B-value	B (25/50), tolerance ±3%		3375		K
B-value	B (25/100), tolerance ±3%		3433		K

Module

Parameter	Conditions	Symbol	Value			Unit
Isolation test voltage	RMS, f=50Hz, t=1min	V _{ISOL}	3200			V
Internal isolation			Al ₂ O ₃			
Creepage distance	terminal to heatsink terminal to terminal		11.5 6.8			mm
Clearance			9.4 5.5			mm
Comparative tracking index		CTI	>400			
RTI Elec.	housing	RTI	140			
Storage temperature		T _{stg}	-40		125	°C
Mounting torque for modul mounting		M	2.0		5.0	Nm
Weight		W		268		g

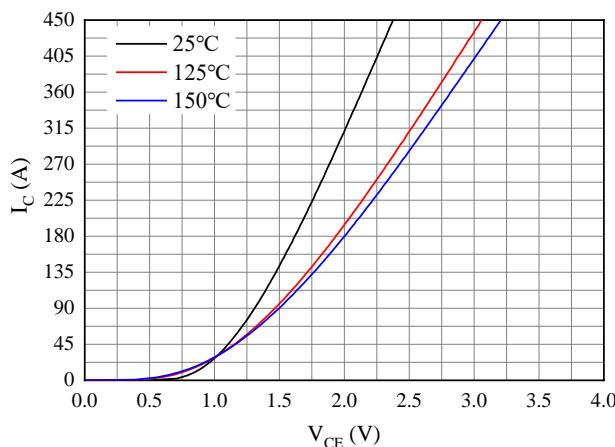
IGBT T1/T4


Fig 1. Typical output characteristics ($V_{GE}=15V$)

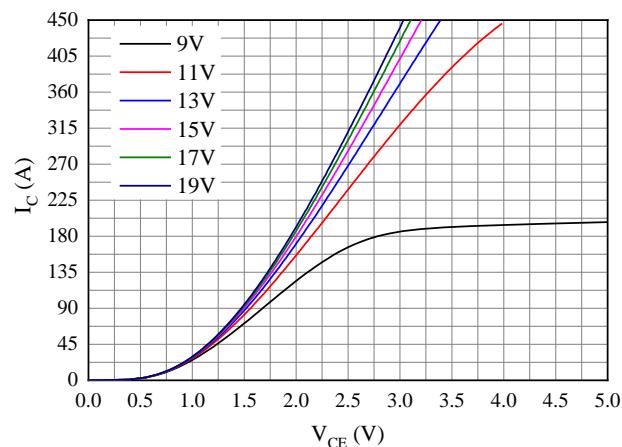


Fig 2. Typical output characteristics ($T_{vj}=150^\circ C$)

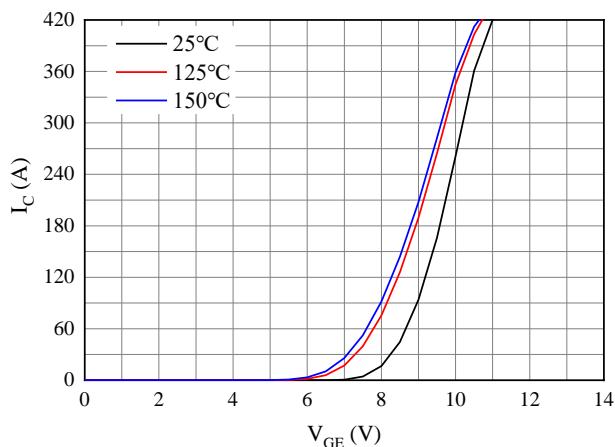


Fig 3. Typical transfer characteristic($V_{CE}=20V$)

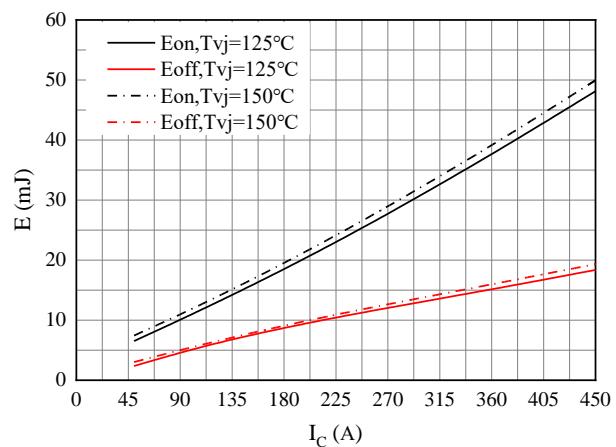


Fig 4. Switching losses of IGBT,
 $V_{GE}=\pm 15V$, $R_g=5\Omega$, $V_{CE}=600V$

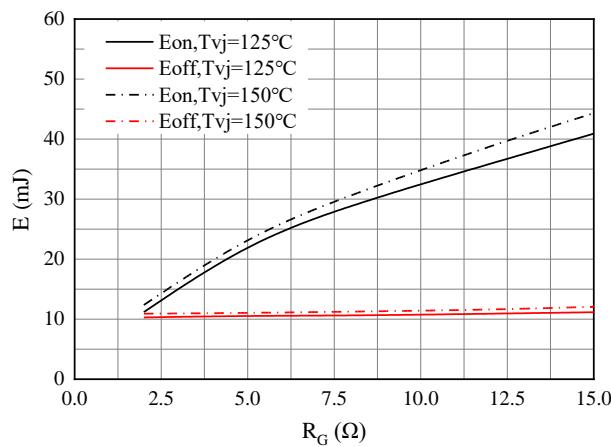


Fig 5. Switching losses of IGBT,
 $V_{GE}=\pm 15V$, $I_c=225A$, $V_{CE}=600V$

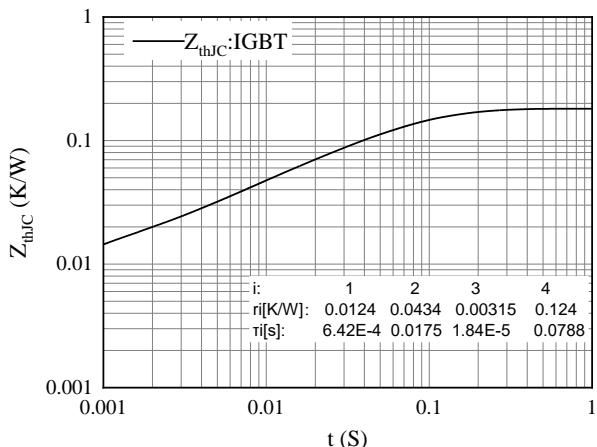


Fig 6. Transient thermal impedance IGBT,
 $Z_{thJC}=f(t)$

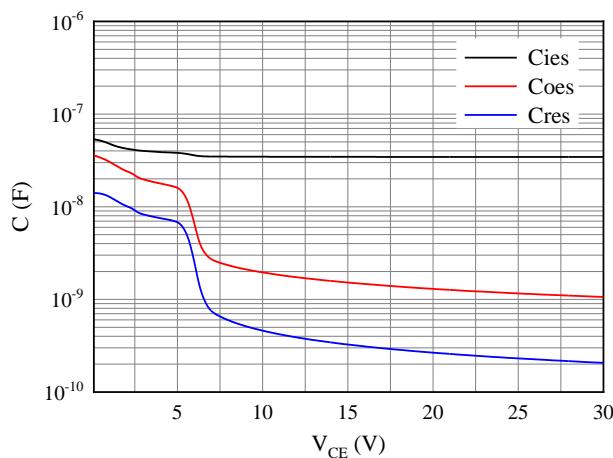


Fig 7. Capacitance characteristic

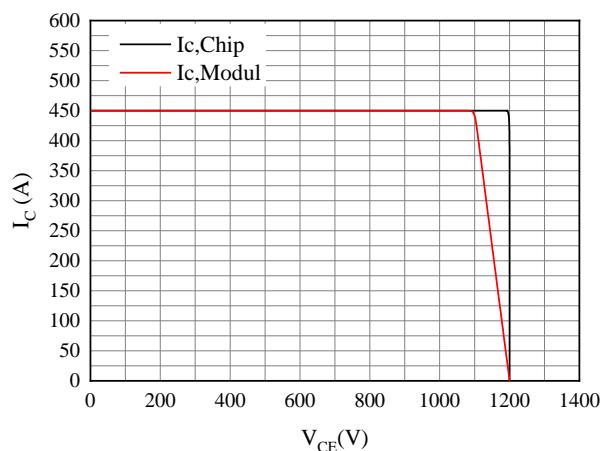


Fig 8. RBSOA

V_{GE}=±15V, R_{goff}=5Ω, T_{vj}=150°C

IGBT T2/T3

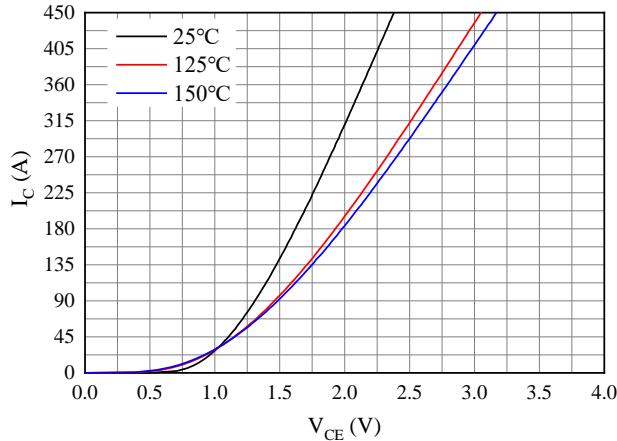


Fig 9. Typical output characteristics (V_{GE}=15V)

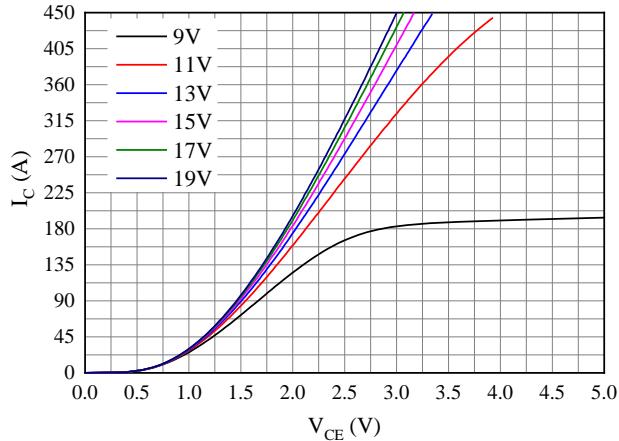


Fig 10. Typical output characteristics (T_{vj}=150°C)

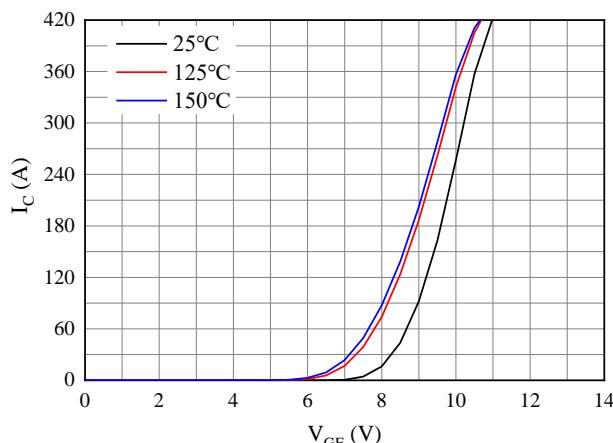


Fig 11. Typical transfer characteristic(V_{CE}=20V)

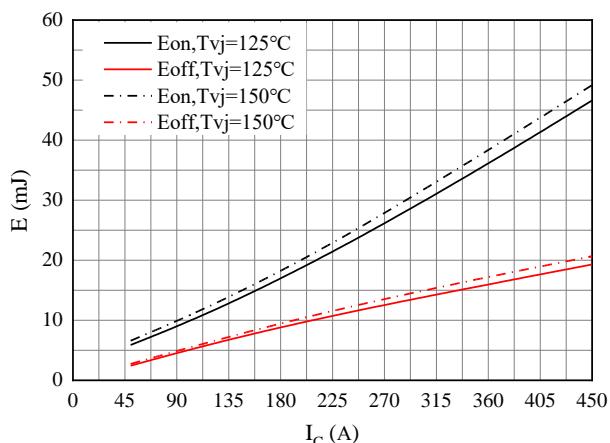


Fig 12. Switching losses of IGBT,

V_{GE}=±15V, R_g=5Ω, V_{CE}=600V

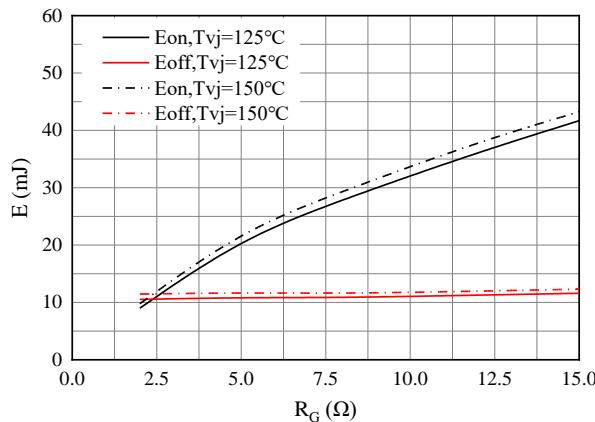


Fig 13. Switching losses of IGBT,
 $V_{GE}=\pm 15V, I_c=225A, V_{CE}=600V$

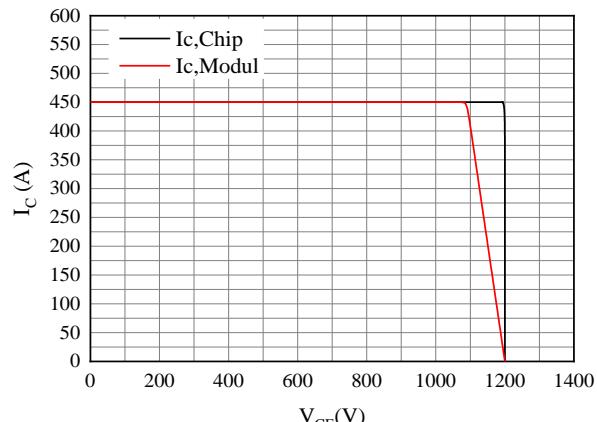


Fig 14. Transient thermal impedance IGBT,
 $Z_{thJC}=f(t)$

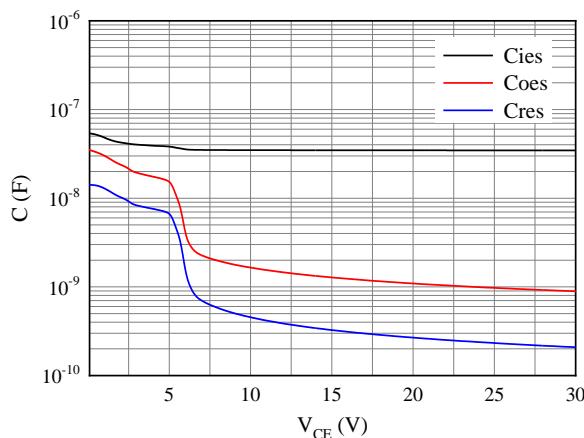


Fig 15. Capacitance characteristic

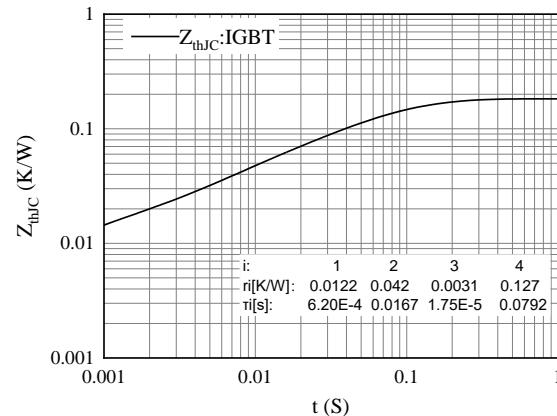


Fig 16. RBSOA
 $V_{GE}=\pm 15V, R_{goff}=5\Omega, T_{vj}=150^\circ C$

Diode D1/D4

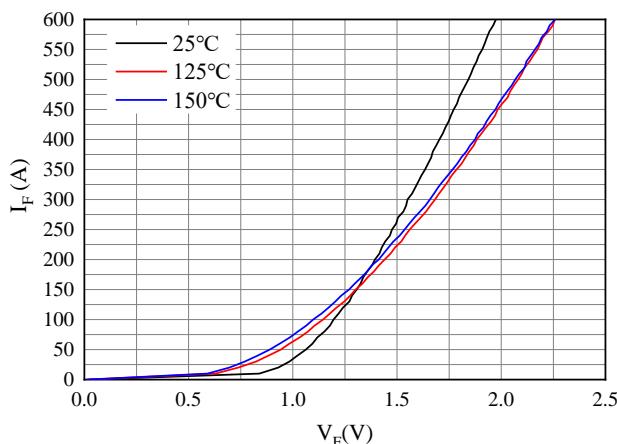


Fig 17. Forward characteristic of Diode

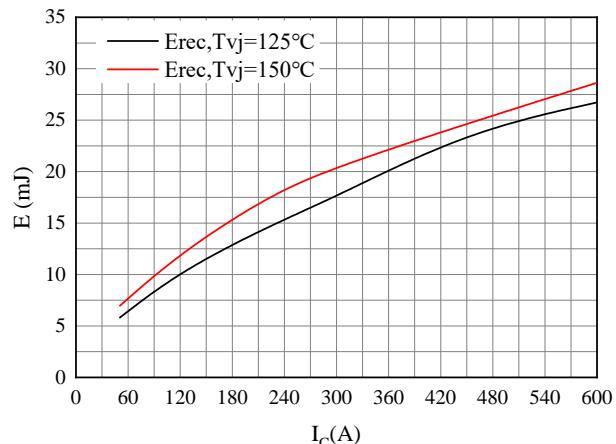


Fig 18. Switching losses of Diode
 $R_g=5\Omega, V_{CE}=600V$

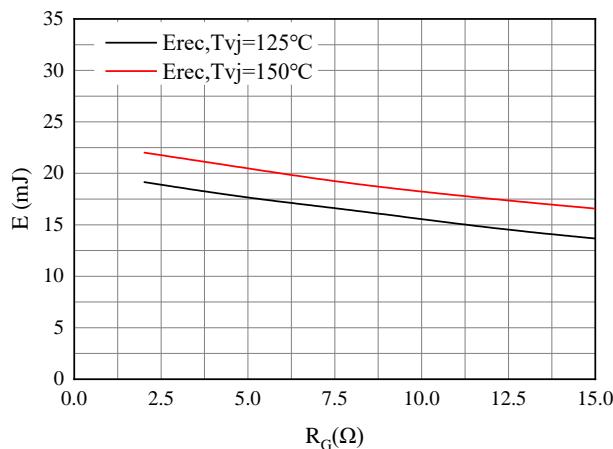


Fig 19. Switching losses of Diode

I_F = 300A, V_{CE} = 600V

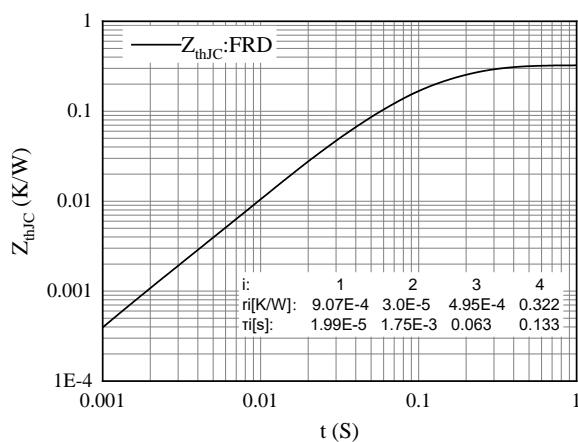


Fig 20. Transient thermal impedance FRD , Z_{thJC}=f(t)

Diode D2/D3

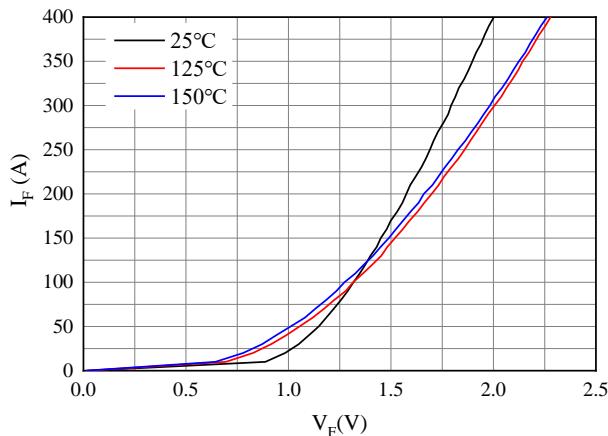


Fig 21. Forward characteristic of Diode

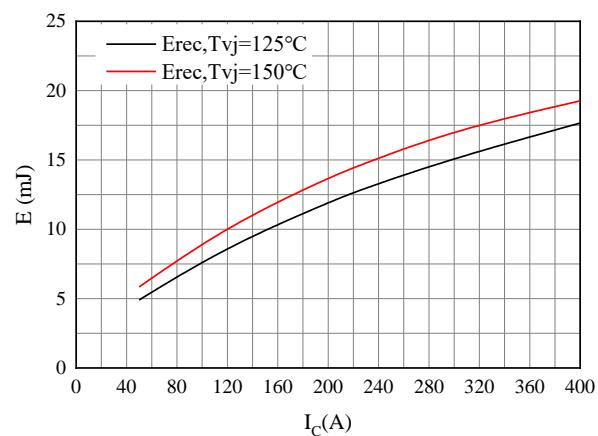


Fig 22. Switching losses of Diode

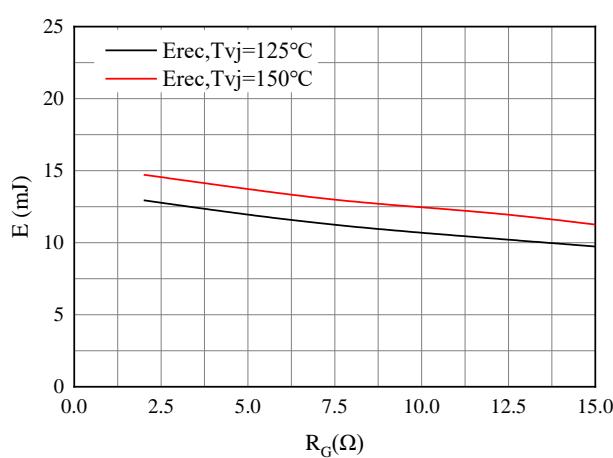


Fig 23. Switching losses of Diode

I_F = 200A, V_{CE} = 600V

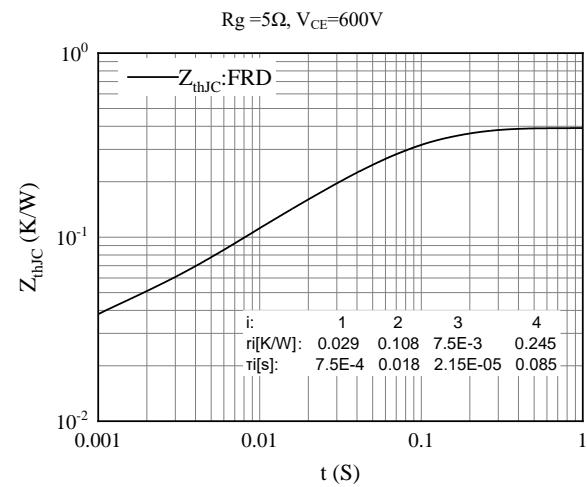


Fig 24. Transient thermal impedance FRD , Z_{thJC}=f(t)

Diode D5/D6

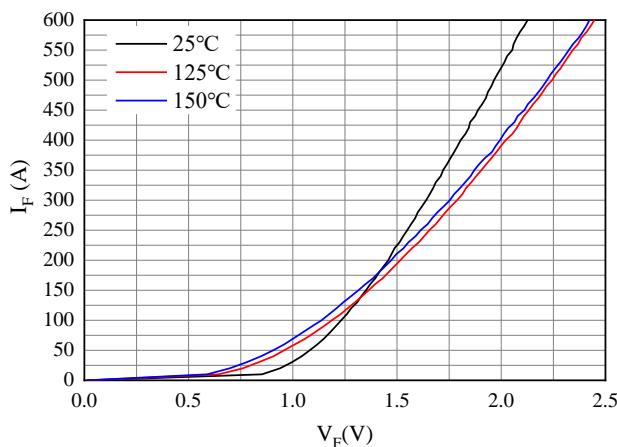


Fig 25. Forward characteristic of Diode

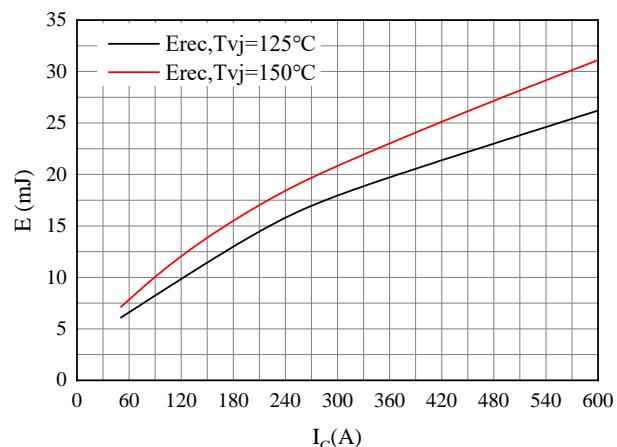


Fig 26. Switching losses of Diode
 $R_g = 5\Omega$, $V_{CE} = 600\text{V}$

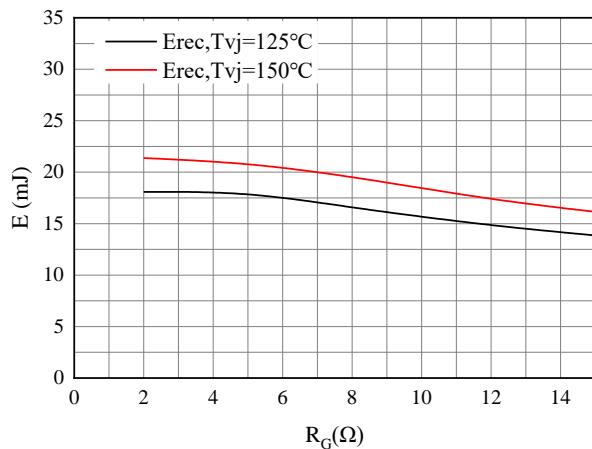


Fig 27. Switching losses of Diode
 $I_F = 300\text{A}$, $V_{CE} = 600\text{V}$

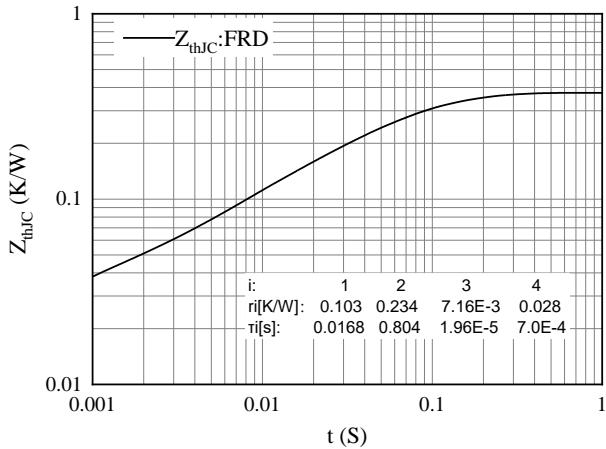


Fig 28. Transient thermal impedance FRD ,
 $Z_{thJC} = f(t)$

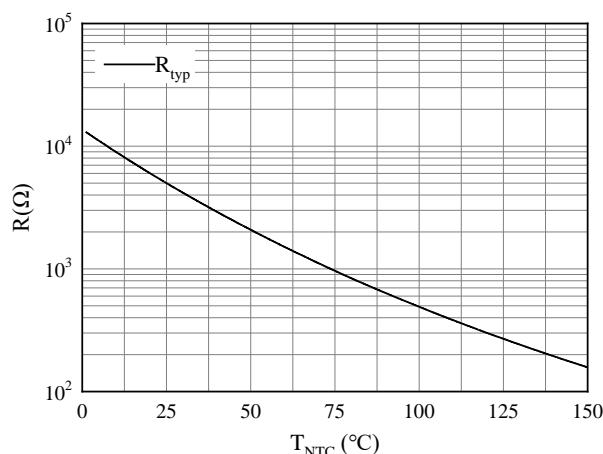
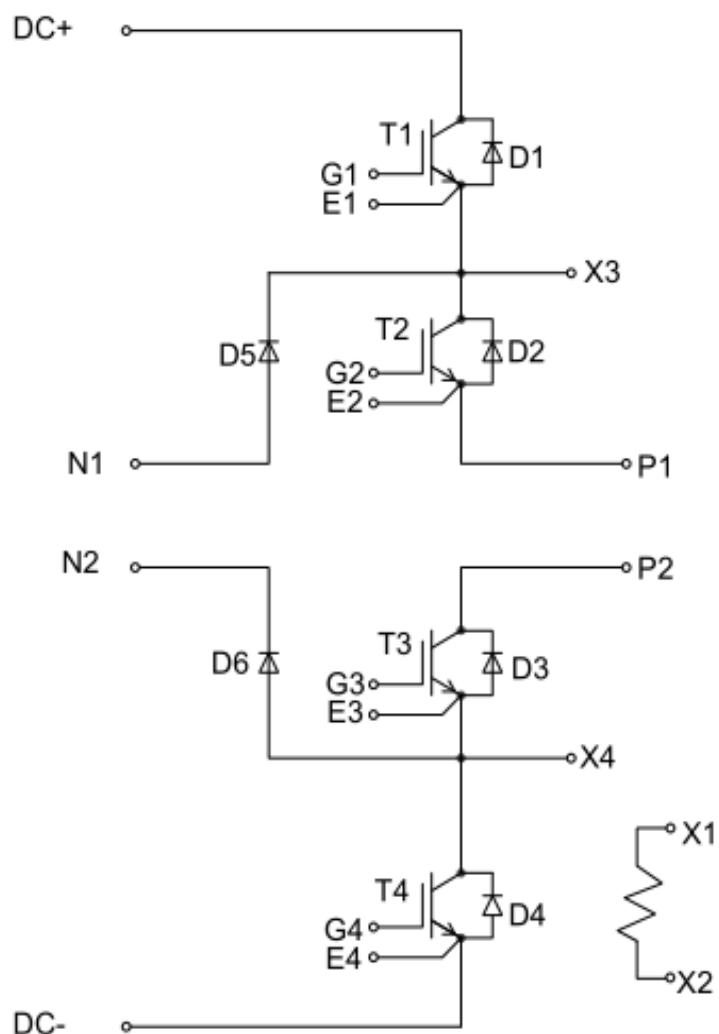


Fig 29. NTC-Thermistor-temperature characteristic

Circuit Diagram

Package outlines
